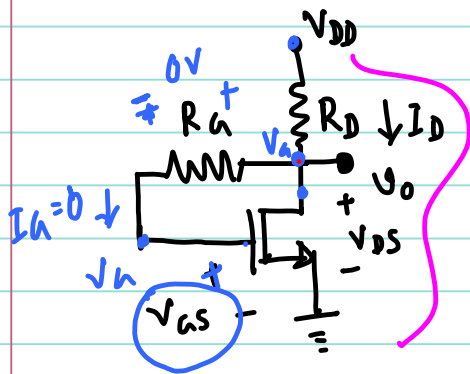


(C) Biassing using Drain to Gate Feedback Resistor:



$$V_{GS} = V_{DS} ; \quad V_{DS-sat} = V_{GS} - V_{TH}$$

Saturation

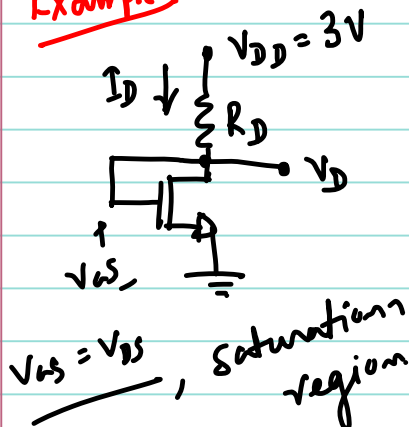
$$V_{DD} = I_D R_D + V_{DS}$$

$$V_{DD} = I_D R_D + V_{GS}$$

↳ Negative feedback, Stability

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Example:



$$\rightarrow V_{TH} = 0.6V, \quad \mu_n C_{ox} = 200 \mu A/V^2$$

$$L = 0.8 \mu m, \quad W = 4 \mu m$$

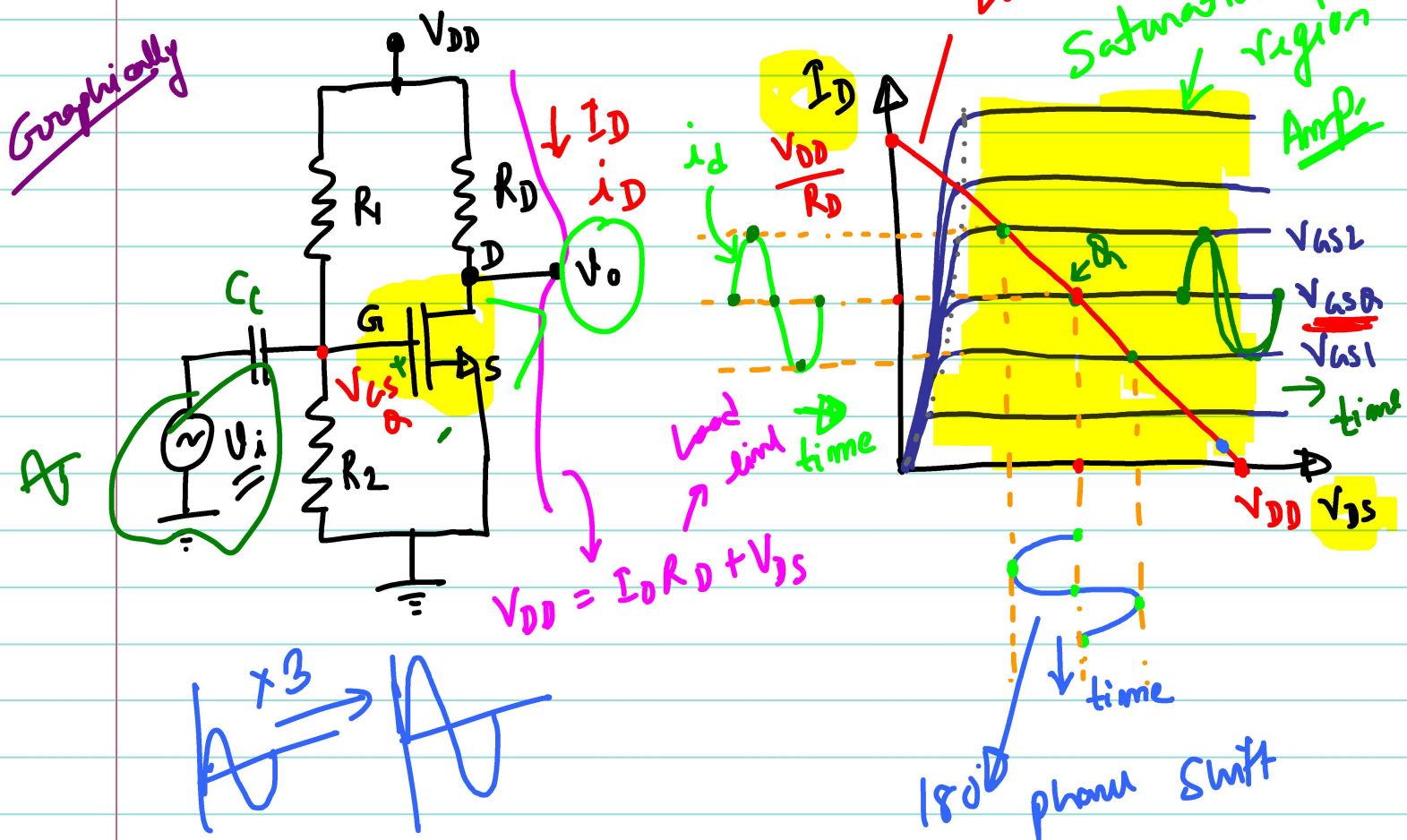
$$\rightarrow I_D = 80 \mu A$$

Find V_D .

$$I_D = \frac{1}{2} \mu_n C_{ox} \frac{W}{L} (V_{GS} - V_{TH})^2$$

$$V_{GS} = V_D = 1V \approx V_{DS} ; \quad \underline{V_D = 1V}$$

MOSFET as amplifier:



→ Linear Amplifier

→ AC + DC

Notation $\left\{ \begin{array}{l} V_{GS} \rightarrow \text{total} \\ V_{GS} \rightarrow \text{DC}, \quad V_{gs} \rightarrow \text{AC} \end{array} \right.$ instantaneous values of V_{GS}

$$\rightarrow \underline{V_{as}} = \underline{V_{as0}} + \underline{V_i} = \underline{V_{as0}} + \underline{V_{gs}}$$

$$\rightarrow i_D = k_n (V_{GS} - V_{TH})^2$$

$$V_{as} = V_{as0} + V_{gs}$$

$$i_D = k_n (V_{as} - V_{tn})^2$$

$$= k_n [V_{as0} + V_{gs} - V_{tn}]^2$$

$$= k_n [(V_{as0} - V_{tn}) + V_{gs}]^2$$

$$I_{D0} + i_d = i_D = \underbrace{k_n (V_{as0} - V_{tn})^2}_{I_{D0}} + \underbrace{2k_n (V_{as0} - V_{tn}) V_{gs}}_{i_d} + \underbrace{V_{gs}^2}_{\text{non-linear}}$$

Linear Amp.

, $i_d \propto V_{gs}$

$(\frac{W}{L})$

if, $V_{gs} \ll 2(V_{as0} - V_{tn})$

$$i_d = 2k_n (V_{as0} - V_{tn}) V_{gs}$$

$$g_m = \left. \frac{\partial i_d}{\partial V_{gs}} \right|_{V_{as0}} = 2k_n (V_{as0} - V_{tn}) = 2k_n \sqrt{\frac{I_{D0}}{k_n}}$$

Trans conductance

$$I_{D0} = k_n (V_{as0} - V_{tn})^2$$

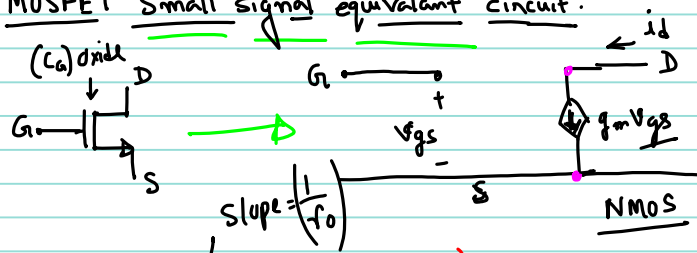
$$V_{as0} - V_{tn} = \sqrt{\frac{I_{D0}}{k_n}}$$

$$g_m = 2 \sqrt{I_{D0} k_n}$$

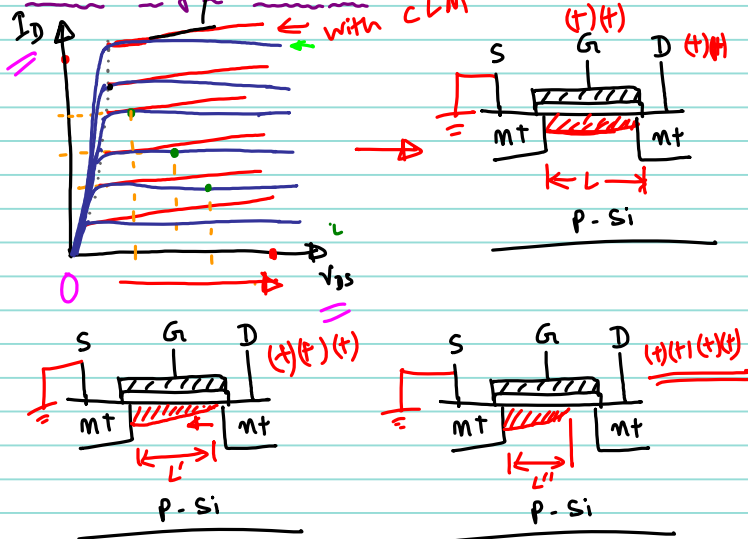
$$g_m \propto k_n \propto \left(\frac{W}{L}\right)$$

$\tau_R = \frac{1}{\omega_c}$ range of freq. for which gate is open circuit.

MOSFET Small signal equivalent circuit:



Channel length modulation: (CLM)

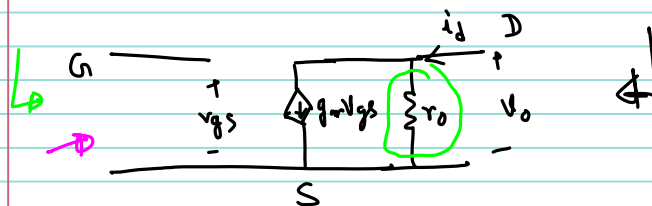


$\uparrow I_D \propto \left(\frac{W}{L}\right) \downarrow L$ is decreasing.

$$I_D = k_n (V_{GS} - V_{th})^2 (1 + \lambda V_{DS})$$

$$r_o = \left(\frac{\partial I_D}{\partial V_{DS}} \right)^{-1} = \left[k_n (V_{GS} - V_{th})^2 \lambda \right]^{-1}$$

$$r_o = [I_{DQ} \lambda]^{-1} = \frac{1}{\lambda I_{DQ}}$$



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For PMOS:

